

● PRINTER RUSH ●

(PTO ASSISTANCE)

Application : <u>10/080560</u>	Examiner : <u>Heneghan</u>	GAU : <u>2134</u>
From: <u>LAS</u>	Location: <u>IDC</u> FMF FDC	Date: <u>7/20/05</u>

Tracking #: epm 10/080560 Week Date: 3/28/05

DOC CODE	DOC DATE	MISCELLANEOUS
<input checked="" type="checkbox"/> 1449	<u>10-1-2004</u>	<input type="checkbox"/> Continuing Data <input type="checkbox"/> Foreign Priority <input type="checkbox"/> Document Legibility <input type="checkbox"/> Fees <input type="checkbox"/> Other
<input type="checkbox"/> IDS	<u>Page 2 of 2</u>	
<input type="checkbox"/> CLM		
<input type="checkbox"/> IIFW		
<input type="checkbox"/> SRFW		
<input type="checkbox"/> DRW		
<input type="checkbox"/> OATH		
<input type="checkbox"/> 312		
<input type="checkbox"/> SPEC		

[RUSH] MESSAGE:

Please verify U.S. Reference RE 31,375, 11/13/1984,
Davidson.

Thank you

[XRUSH] RESPONSE: Correct number is RE 31735.

INITIALS: def

NOTE: This form will be included as part of the official USPTO record, with the Response document coded as XRUSH.
 REV 10/04

#14

SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

 ATTY. DOCKET NO.
070602-0247

 SERIAL NO.
10/080,560

 APPLICANT
Jack Elias Seitner

 FILING DATE
February 25, 2002

 GROUP
2313

(PTO-1449)

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patent or Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
JH 9/27/04	1.	US 2003/0118186 A1	08/26/2003	Gilley	
JH 9/27/04	2.	US 2001/0038274 A1	11/01/2001	Antoine	
JH 9/27/04	3.	US Re. 31,976 735	11/13/1984	Davidson	
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number & Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
						Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

ORC 336463-1.070602.0247